

TEST REPORT

: Jiangsu SEUIC Technology Co.,Ltd. **APPLICANT**

: Portable Data Collection Terminal PRODUCT NAME

MODEL NAME : CRUISE 1

BRAND NAME : CRUISE/SEUIC

FCC ID : 2AC68-CRUISE1S

STANDARD(S) : 47 CFR Part 15 Subpart B

RECEIPT DATE : 2019-12-05

TEST DATE : 2019-12-19 to 2019-12-27

ISSUE DATE : 2020-02-27

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Change History						
Version Date Reason for change						
1.0	2020-02-27	First edition				



Note: Provide by applicant

1. Technical Information

1. recinical information

1.1. Applicant and Manufacturer Information

Applicant:	Jiangsu SEUIC Technology Co.,Ltd.
Applicant Address:	NO.15 Xinghuo Road, Nanjing New & High Technology Industry Development Zone, 210061, Nanjing City, Jiangsu Province, China
Manufacturer:	Jiangsu SEUIC Technology Co.,Ltd.
Manufacturer Address:	NO.15 Xinghuo Road, Nanjing New & High Technology Industry Development Zone, 210061, Nanjing City, Jiangsu Province, China

1.2. Equipment Under Test (EUT) Description

Product Name:	Portable Data Collection Terminal					
Serial No:	(N/A, marked #1 by test site)					
Hardware Version:	SLB761X_MB_V1.00_PCB					
Software Version:	D700S_G_V0.3.0					
SIM Cards	SIM 1 and SIM 2 is a chipset unit and tested as a single chipset. The					
Description:	SIM 1 is chosen for test					
Tx Frequency:	GSM850: 824 MHz ~ 849 MHz					
	GSM1900: 1850 MHz ~ 1910 MHz					
	WCDMA Band II: 1850 MHz ~ 1910 MHz					
	WCDMA Band V: 824 MHz ~ 849 MHz					
	CDMA 800MHz (BC 0): 824 MHz ~ 849 MHz					
	LTE Band 5: 824 MHz ~ 849 MHz					
	LTE Band 7: 2500 MHz ~ 2570 MHz					
	LTE Band 38: 2570MHz ~ 2620MHz					
	LTE Band 40: 2305MHz ~ 2315MHz, 2350MHz ~ 2360MHz					
	LTE Band 41: 2555 MHz ~2655 MHz					
	Bluetooth 4.0: 2402 MHz ~ 2480 MHz					
	802.11b/g/n: 2412 MHz ~2472 MHz					
	802.11a/ac/n: 5180 MHz ~ 5240 MHz;5260 MHz ~ 5320 MHz;					
	5500 MHz ~ 5700 MHz;5745MHz ~ 5825 MHz;					
	NFC:13.56MHz					





	1						
Rx Frequency:	GSM850: 869 M						
	GSM1900: 1930	MHz ~ 1990 MHz					
		: 1930 MHz ~ 1990 MHz					
		': 869 MHz ~ 894 MHz					
		(BC 0): 869 MHz ~ 894 MHz					
	LTE Band 5: 869 MHz ~ 894 MHz						
		20 MHz ~ 2690 MHz					
		570MHz ~ 2620MHz					
		305MHz ~ 2315MHz, 2350MHz ~ 2360MHz					
		555 MHz ~2655 MHz					
		402 MHz ~ 2480 MHz					
	_	12 MHz ~ 2472 MHz					
		80 MHz ~ 5240 MHz;5260 MHz ~ 5320 MHz;					
		00 MHz;5745MHz ~ 5825 MHz;					
	NFC:13.56MHz	0/CLONACC:4550 MILE 4640 MILE					
A : !!!		o/GLONASS:1559 MHz ~ 1610 MHz					
Ancillary	AC Adapter	N/A					
Equipment:	Brand Name:	N/A					
	Model No.:	TPA-23A050200UU01					
	Serial No.:	(N/A, marked #1 by test site)					
	Rated Input: Rated Output:	100-240V~50/60Hz 0.30A 5.00V=2.00A					
	•						
	Manufacturer:	SHENZHEN TIANYIN ELECTRONICS CO.,LTD					
	Battery						
	Brand Name:	N/A					
	Model No.:	BT01700CRUISE					
	Serial No.:	(N/A, marked #1 by test site)					
	Capacity: 4500mAh						
	Rated Voltage: 3.80V						
	Charge Limit:	4.35V					
	Manufacturer:	ICON ENERGY SYSTEM (SHENZHEN) CO.,LTD.					

Note:

1. The Digital Mobile Phone supports GSM850MHz, 1900MHz, GPRS, EDGE, WCDMA Band II, Band V, HSDPA, HSPA+,CDMA/CDMA1xRTT/EVDO Rev.0/Rev.A BC0, LTE Band5/738/40/41, 2.4G WIFI and 5G WIFI, Bluetooth, NFC and GPS/Galileo/GLONASS/BDS.



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- The EUT is equipped with a T-Flash card slot, two SIM card slots and a Micro USB port which can be connected to ancillary equipments.
- For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.





2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title		
1	47 CFR Part 15	Radio Frequency Devices		

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date Test Engineer		Result	Method	
						determination	
						Remark	
1	15.107	Conducted Emission	2019.12.27	Lin Jiayong	PASS	No deviation	
2	15.109	Radiated Emission	2019.12.19	Li Zihao	PASS	No deviation	

NOTE 1: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.

NOTE 2: Additions to, deviation, or exclusions from the method shall be judged in the "method determination" column of add, deviate or exclude from the specific method shall be explained in the "Remark" of the above table.





2.2. EUT Setup and Operating Conditions

Test Iten	1	
Radiated	ΙE	mission
Mode 1	:	EUT + ADAPTER + EARPHONE+ Recording + NFC idle
Mode 2	:	EUT+ADAPTER+EARPHONE+WWAN idle + WIFI idle + Bluetooth idle
Mode 3	:	EUT + ADAPTER + PC + data transmission + GPS/Galileo/GLONASS/BDS Rx
Conduct	ed	Emission
Mode 1	:	EUT + ADAPTER + EARPHONE+ Recording + NFC idle
Mode 2	:	EUT+ADAPTER+EARPHONE+WWAN idle + WIFI idle + Bluetooth idle
Mode 3	:	EUT + ADAPTER + PC + data transmission + GPS/Galileo/GLONASS/BDS Rx
Remark:		
		test modes in boldface were the worst cases of conducted emission, radiated nly the test data of these modes was reported.

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106





3. 47 CFR Part 15B Requirements

3.1. Conducted Emission

3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the ACpower line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

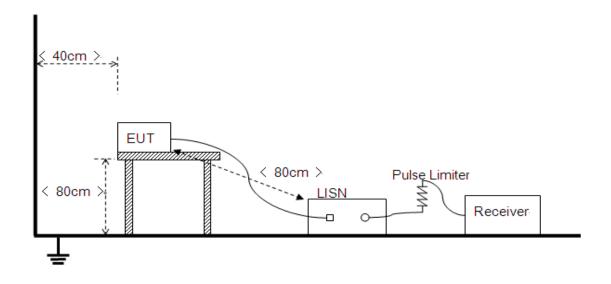
Frequency range	Conducted Limit (dBµV)				
(MHz)	Quasi-peak	Average			
0.15 - 0.50	66 to 56	56 to 46			
0.50 - 5	56	46			
5 - 30	60	50			

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.





The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

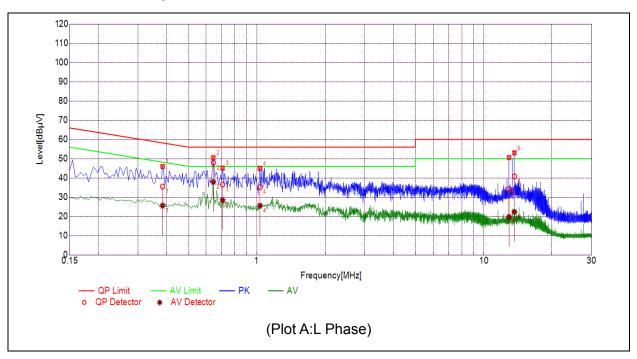
The power strip or extension cord has been investigated to make sure that the LISN integrity inma intained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

3.1.3. Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

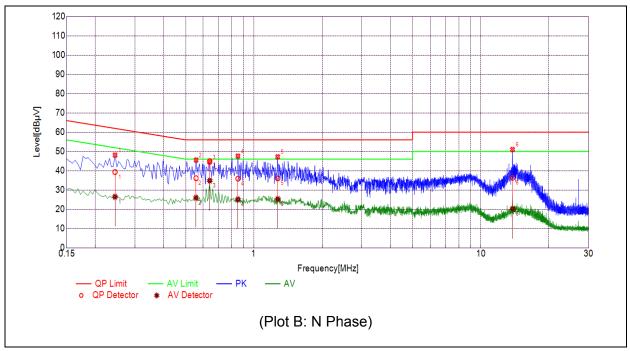


A. Test Plot and Suspicious Points:



NO.	Fre.	Emission L	evel (dBµV)	Limit (d	dΒμV)	Power-line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.3839	35.55	25.60	58.19	48.19		PASS
2	0.6452	47.92	37.94	56.00	46.00		PASS
3	0.7079	36.55	28.43	56.00	46.00		PASS
4	1.0329	35.25	25.57	56.00	46.00	Line	PASS
5	12.9718	34.25	19.72	60.00	50.00		PASS
6	13.7059	40.84	22.31	60.00	50.00		PASS





NO.	Fre.	Emission L	evel (dBµV)	Limit (d	dΒμV)	Dower line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.2443	39.29	26.47	61.95	51.95	Neutral	PASS
2	0.5547	36.10	25.97	56.00	46.00		PASS
3	0.6411	44.99	34.83	56.00	46.00		PASS
4	0.8526	35.90	25.14	56.00	46.00		PASS
5	1.2750	36.01	25.30	56.00	46.00		PASS
6	13.8639	36.34	20.23	60.00	50.00		PASS

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3.2. Radiated Emission

3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength Limitation at 3m Measurement Dist				
range (MHz)	(μV/m)	(dBµV/m)			
30.0 - 88.0	100	20log 100			
88.0 - 216.0	150	20log 150			
216.0 - 960.0	200	20log 200			
Above 960.0	500	20log 500			

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- Limitation expressed in dBμV/m is calculated by 20log Emission Level(μV/m).

3.2.2. Frequency range of measurement

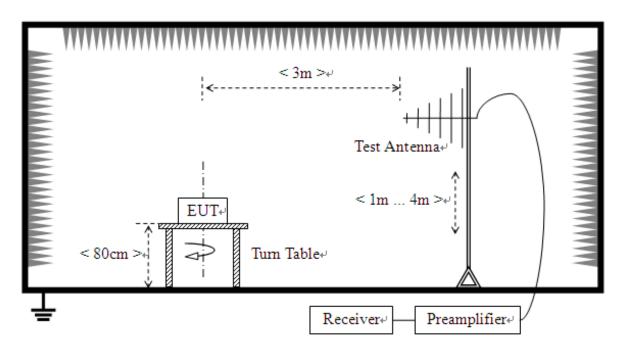
According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measure- ment range (MHz)
Below 1.705	30. 1000. 2000. 5000. 5th harmonic of the highest frequency or 40 GHz, whichever is lower.

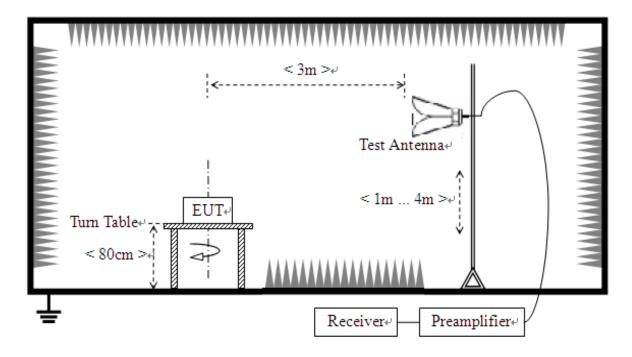


3.2.3. Test Setup

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz







The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted onavariable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz)are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

3.2.4. Test Result

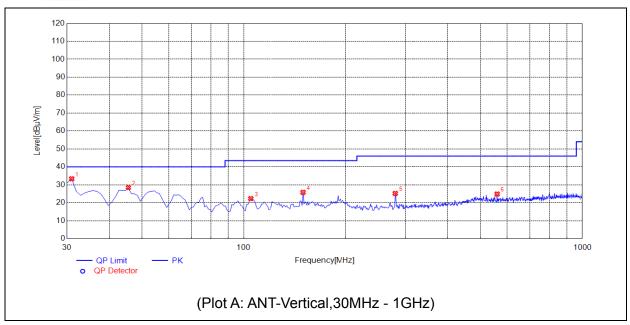
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of emissions which (6GHz-30GHz) are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

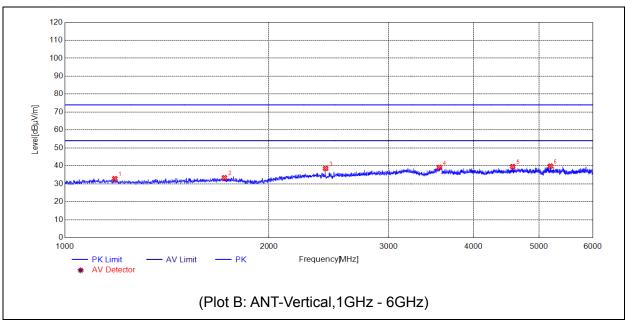






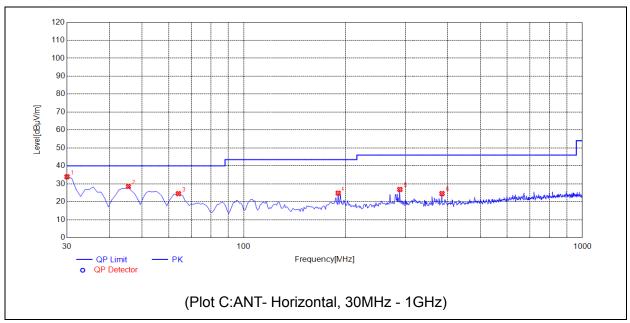
No.	Fre. MHz	Pk dBµV/m	QP dBµV/m	ΑV dBμV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	30.9710	33.35	N.A	N.A	N.A	40.00	N.A	V	PASS
2	45.5355	28.44	N.A	N.A	N.A	40.00	N.A	>	PASS
3	104.7648	22.32	N.A	N.A	N.A	43.50	N.A	>	PASS
4	149.4294	25.81	N.A	N.A	N.A	43.50	N.A	>	PASS
5	279.5395	25.22	N.A	N.A	N.A	46.00	N.A	>	PASS
6	560.1502	24.86	N.A	N.A	N.A	46.00	N.A	V	PASS





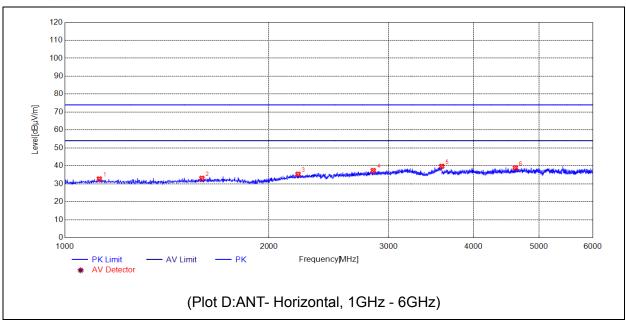
No.	Fre. MHz	Pk dBµV/m	QP dBµV/m	AV dBμV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1183.0366	32.89	N.A	N.A	74.00	N.A	54.00	V	PASS
2	1719.1438	33.44	N.A	N.A	74.00	N.A	54.00	V	PASS
3	2420.2841	38.56	N.A	N.A	74.00	N.A	54.00	V	PASS
4	3564.5129	39.20	N.A	N.A	74.00	N.A	54.00	V	PASS
5	4573.7147	39.60	N.A	N.A	74.00	N.A	54.00	V	PASS
6	5194.8390	39.86	N.A	N.A	74.00	N.A	54.00	V	PASS





No.	Fre. MHz	Pk dBµV/m	QP dBµV/m	ΑV dBμV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	30.0000	33.91	N.A	N.A	N.A	40.00	N.A	Н	PASS
2	45.5355	28.50	N.A	N.A	N.A	40.00	N.A	Н	PASS
3	63.9840	24.52	N.A	N.A	N.A	40.00	N.A	Н	PASS
4	189.2392	24.80	N.A	N.A	N.A	43.50	N.A	Н	PASS
5	288.2783	26.87	N.A	N.A	N.A	46.00	N.A	Н	PASS
6	384.4044	24.60	N.A	N.A	N.A	46.00	N.A	Н	PASS





No.	Fre. MHz	Pk dBµV/m	QP dBµV/m	ΑV dBμV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1123.0246	32.73	N.A	N.A	74.00	N.A	54.00	Н	PASS
2	1593.1186	33.07	N.A	N.A	74.00	N.A	54.00	Н	PASS
3	2206.2412	35.35	N.A	N.A	74.00	N.A	54.00	Н	PASS
4	2849.3699	37.41	N.A	N.A	74.00	N.A	54.00	Н	PASS
5	3593.5187	39.79	N.A	N.A	74.00	N.A	54.00	Н	PASS
6	4615.7231	38.94	N.A	N.A	74.00	N.A	54.00	Н	PASS

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Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission Measurement

Measuring Uncertainty for	9kHz-150kHz	±4.1dB
a Level of Confidence of	150kHz-30MHz	±3.7dB
95%(U=2Uc(y))		

Uncertainty of Radiated Emission Measurement

Measuring Uncertainty for	30MHz-200MHz	±5.06dB
a Level of Confidence of	200MHz-1000MHz	±5.24dB
95%(U=2Uc(y))	1GHz-6GHz	±5.18dB
	6GHz-18GHz	±5.48dB





Annex B Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.			
	Morlab Laboratory			
Laboratory Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang			
	Road, Block 67, BaoAn District, ShenZhen, GuangDong			
	Province, P. R. China			
Telephone:	+86 755 36698555			
Facsimile:	+86 755 36698525			

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory		
	FL.3, Building A, FeiYang Science Park, No.8 LongChang		
Address:	Road, Block 67, BaoAn District, ShenZhen, GuangDong		
	Province, P. R. China		

3. Accreditation Certificate

Accredited Testing	The FCC designation number is CN1192.	
Laboratory:	Test firm registration number is 226174.	
	(Shenzhen Morlab Communications Technology Co., Ltd.)	

4. Test Software Utilized

Model	Version Number	Producer		
JS32-RE	Version 2.0.2.0	Tonscend		
TS+ -[JS32-CE]	Version2.5.0.0	Tonscend		





5. Test Equipments Utilized

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2019.04.09	2020.04.08
Test Receiver	R&S	ESPI	101052	2019.04.09	2020.04.08
LISN	Schwarzbeck	NSLK 8127	812744	2019.05.08	2020.05.07
Pulse Limiter (20dB)	VTSD	9561D	9537	2019.05.08	2020.05.07
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-519	2019.05.08	2020.05.07
Test Antenna - Horn	Schwarzbeck	BBHA 9120D	1774	2019.05.08	2020.05.07
Radiated Disturbance Preamplifier	rflight	S020180L320 3	61171/61172	2019.07.12	2020.07.11
Radiated Disturbance Preamplifier	rflight	S10M100L38 02	46732	2019.07.12	2020.07.11
Semi-Anechoic Chamber	CRT	9m*6m*6m	N/A	2017.01.12	2020.01.11
PC Adapter	Delta electronics industry co. LTD	A1466	C2QJJ1X1DR VD	N/A	N/A
PC	Desigend by apple in california Assembled in China	A1436	SU10473-120 06	N/A	N/A
TF card	Kingston	SDCS/32G	B0686-011.A OLFTS	N/A	N/A

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